

Over the Air Test Solution for New 5G / mmWave Band Wireless ICs

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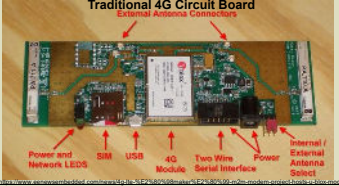


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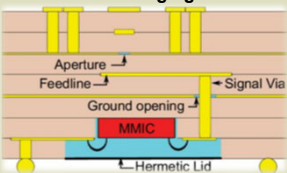
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Overview of AiP-based wireless IC technology



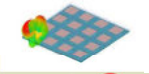
Traditional 4G Circuit Board



Classic AiP Packaging

Antenna-in-Package (AiP) solution:

- The AiP solution is a combination of an antenna or antenna array with an RFIC die into a standard chip scale package
- Compared to traditional RFIC mounted on a PCB, AiP has higher integration scale and smaller parasitics.
- The packaging material could be high-resistivity silicon, Teflon, ceramics (or low temperature cofired ceramic), or polymers (like liquid crystal polymer) [1][2]



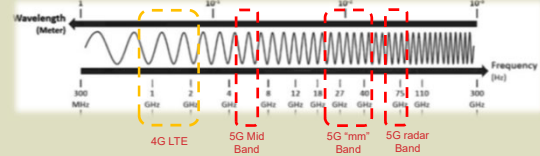

Atsuhiko Shiraki: 122 GHz aperture-coupled stacked patch microchip antenna in LTCC technology 2016 10th European Conference on Antennas and Propagation (EuCAP)

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Overview of AiP-based wireless IC technology

- 5G era ICs functions in much higher frequency



- Pre-5G wireless IC technology limitations
 - Have low antenna gain (directivity)
 - Only provide linear polarization
 - Have high power consumption

➔ Not fit for 5G applications

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5G & mmWave wireless ICs: New Standard



1. Needs much higher gain (directivity)

- Any wireless transmission loss subjects to same rule

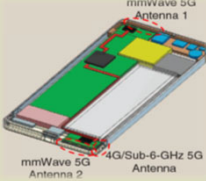
Free Space Path Loss (FSPL):

$$FSPL = 20 \log_{10}(d) + 20 \log_{10}(f) + 20 \log_{10}\left(\frac{4\pi}{c}\right) - G_t - G_r$$

➤ 4G application, single patch antenna Gain ~ 5 - 7 dB

➤ From 2.8 GHz to 28 GHz, FSPL increases 10 dB

➤ 5G wireless ICs typically have higher gain antenna




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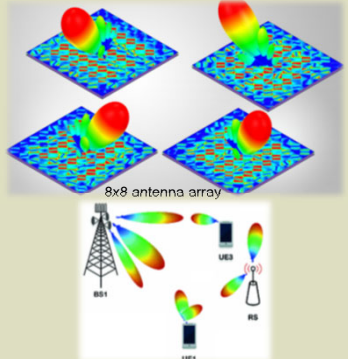
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5G & mmWave wireless ICs: New Standard



2. widely applying antenna array

- Electric phase shift control: steering radiation direction and forming a narrow beam
- High gain and directivity: typical array as small as four antennas can provide 15 - 20 dB gain
- Shorter communication distance: effective communication distance is hundreds of feet instead of several miles;




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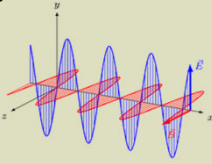
5G & mmWave wireless ICs: New Standard



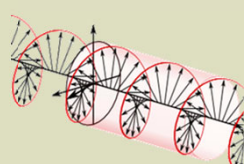
3. widely use antenna circular polarization

circular polarization advantages

- Wide tolerance on antenna alignment
- Resistant to signal magnitude degradation
- Less susceptible to Faraday Effect



electric and magnetic field in linear polarized EM wave
picture from Wikimedia



electric field vectors of a traveling circularly-polarized electromagnetic wave
picture from Wikipedia

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OTA test solutions for 5G / mmWave ICs



New IC test requirement: Summary

- Contactor antenna needs wideband RF performance in high frequency
- Contactor antenna must radiate uniformly in whole antenna array
- Contactor antenna must be adaptable to linear / circular polarized radiation
- Contactor must provide low loss & ultra-wide band signal interface

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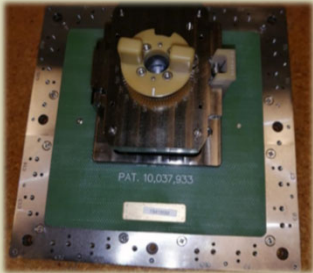
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Solutions for 5G / mmWave OTA Test



5G / mm-wave OTA IC contactor features



- RF test signal is feed to the DUT through contactor antenna
- Contactor antenna radiates uniformly DUT antenna array
- Contactor antenna radiation covers 5G frequency band (23–30 GHz & 38 – 45 GHz)
- Contactor antenna and DUT antenna couple in far field region
- DUT is installed in a wide band low loss test socket during test
- DUT outputs RF signal through high performance signal route (spring probe or xWave solution)
- Contactor input / output sampled by VNA S-parameter analysis

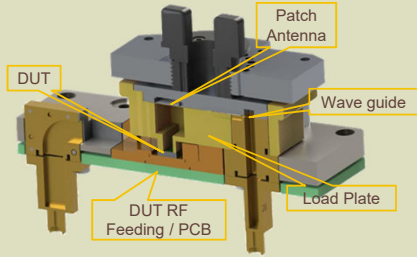
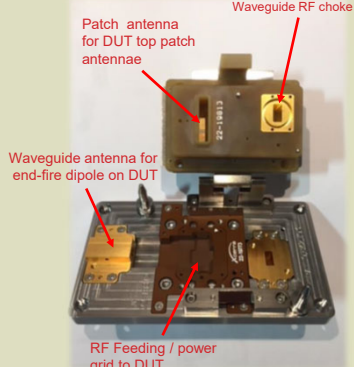

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Solutions for 5G / mmWave OTA Test



Contactor Diagram (cross-section view)


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Solutions for 5G / mmWave OTA Test

- Contactor antenna design guideline

Antenna Gain is given by:

$$Gain(dB) = 10 \cdot \log \left(\frac{4\pi S}{\lambda^2} \cdot \eta_A \right)$$

η_A is the antenna efficiency, S is antenna aperture size

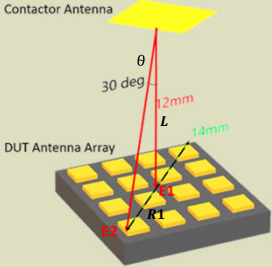
➔ **Bigger aperture provides bigger gain**

-3dB Beam width θ is estimated:

$$Gain_{E1} - Gain_{E2} = 3dB; \theta = 2 \cdot \tan^{-1} \frac{R1}{L}$$

In practice, we find:

➔ **Bigger aperture gives narrower beam**



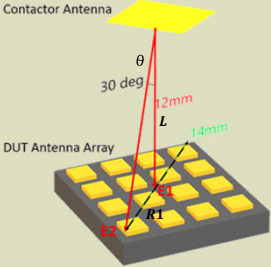
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Solutions for 5G / mmWave OTA Test

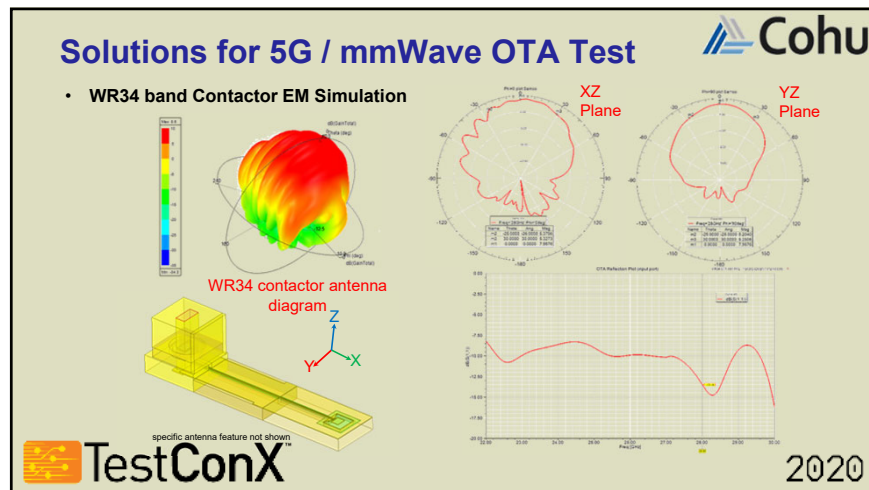
- Contactor antenna design guideline

- For example, contactor antenna with -3 dB beam width 60°
- DUT antenna array diameter: 14mm diagonal
- Antenna coupling distance L:
 $L = 7 / \tan(30^\circ) \approx 12mm$

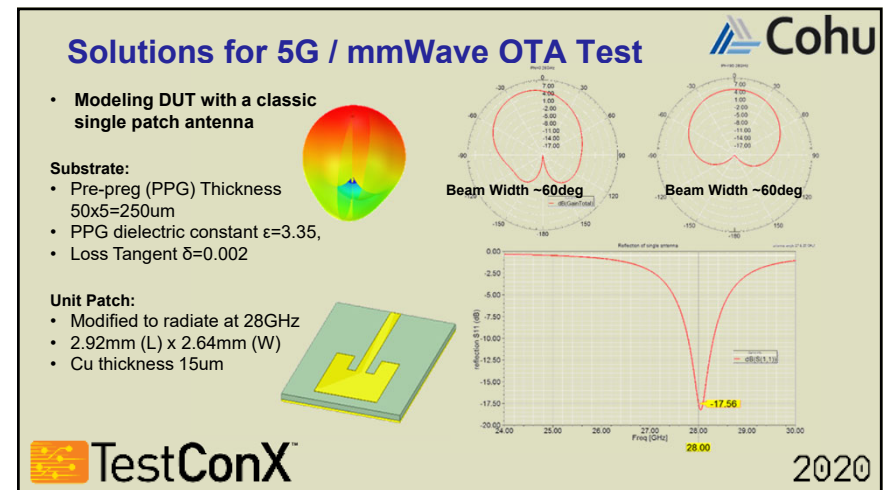


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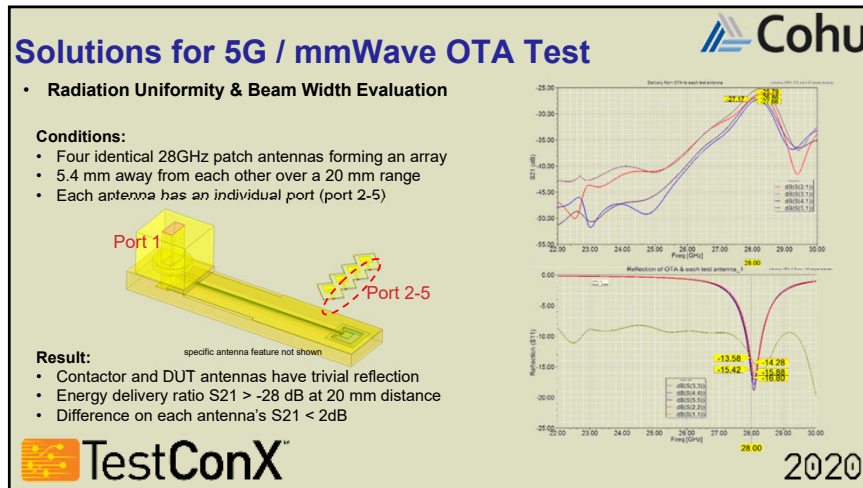
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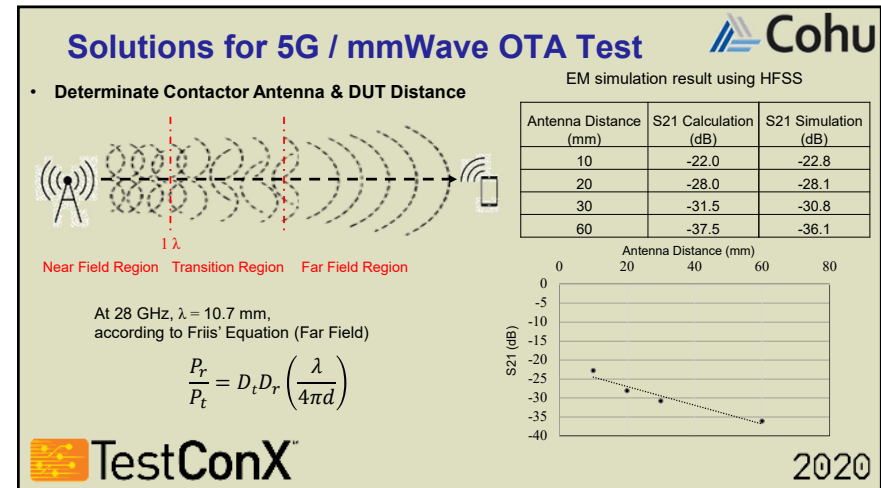
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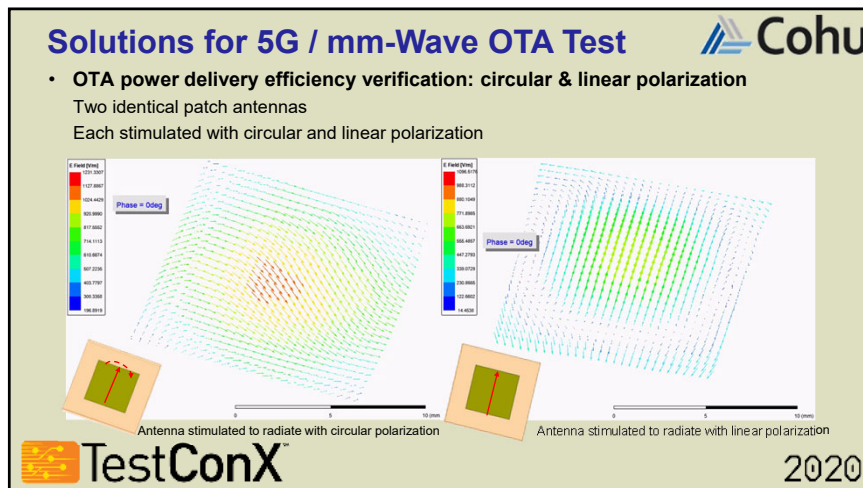
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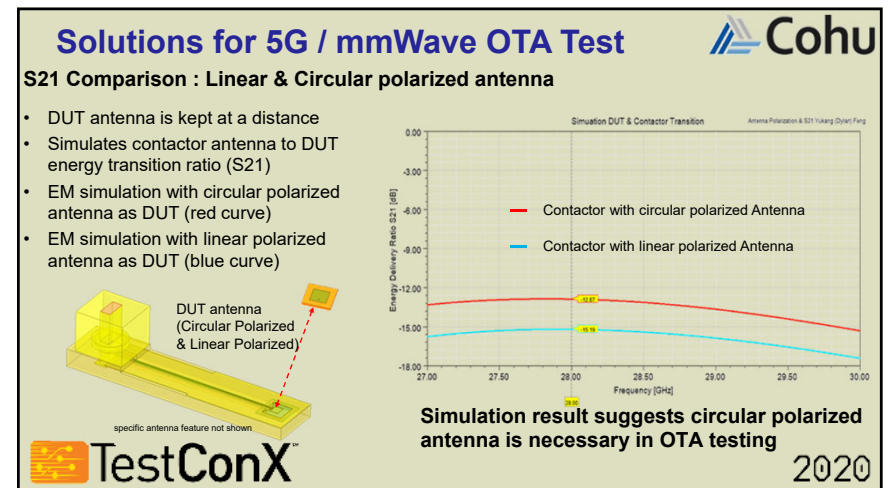
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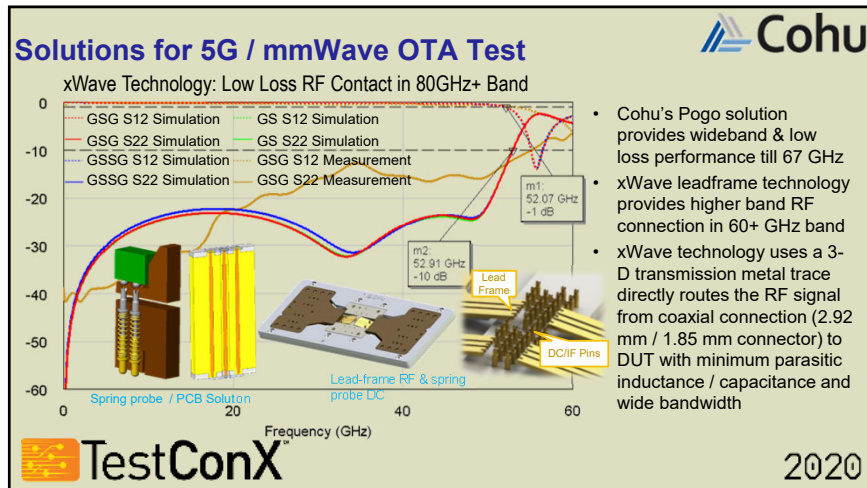
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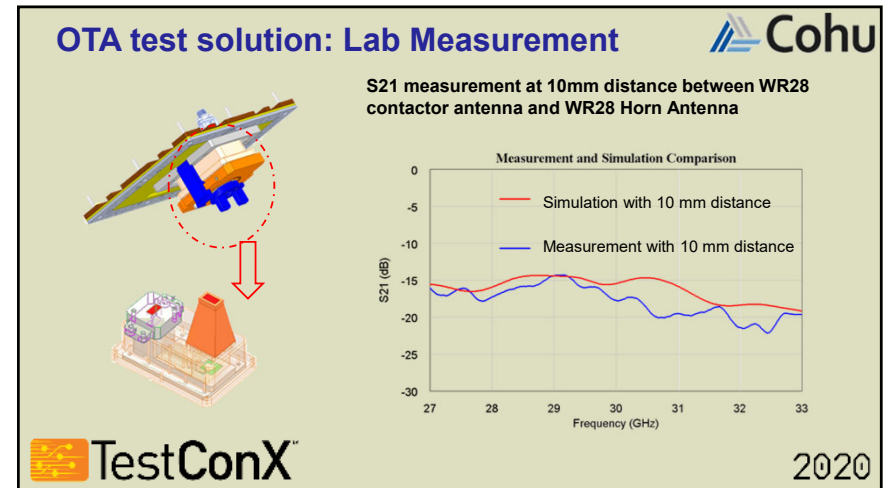
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Conclusions



- In 5G & mmWave Era, wireless ICs work in much higher band, which requires higher antenna gain and electrical beam steering.
- Phase array has become a new standard in wireless IC design
- To test 5G wireless ICs, contactor antenna needs to provide wide beam width and uniform radiation
- To coordinate widely used circular polarization DUT antenna array, the contactor antenna must be able to radiate with circular polarization
- This research suggests the DUTs should be kept in transition region or further distance from contactor antenna
- Low-loss wideband RF feed is also a necessary in the OTA test



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Reference



- [1] Y. P. Zhang, D. Liu, *Antenna-on-Chip and Antenna-in-Package Solutions to Highly Integrated Millimeter-Wave Devices for Wireless Communications* IEEE Transactions on Antennas and Propagation, Volume: 57, Issue: 10, Oct. 2009
- [2] D. Kam, D. Liu, A. Natarajan, *Low-Cost Antenna-in-Package Solutions for 60-GHz Phased-Array Systems* 19th Topical Meeting on Electrical Performance of Electronic Packaging and Systems, 25-27 Oct. 2010



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Thank you for watching!

Please feel free to email me for any question
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